## Machine Learning Theory (CSC 482A/581A) - Lecture 12

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## 1 Recap of risk bounds for VC classes

Let's begin by recasting the risk bounds we established in the last few lectures in a minimax framework. In the bound below, the outer infimum serves as the "min" player and the supremum serves as the "max" player. Let  $\mathcal{F}$  be a class for which  $VCdim(\mathcal{F}) = V$ .

In the agnostic learning setting, we have

$$\inf_{\hat{f}} \sup_{P} \Pr \left( R(\hat{f}) - \inf_{f \in \mathcal{F}} R(f) > \sqrt{\frac{32 \left( V \log \frac{en}{V} + \log \frac{8}{\delta} \right)}{n}} \right) \leq \delta,$$

where

- the probability is with respect to the training sample  $(X_1, Y_1), \ldots, (X_n, Y_n) \stackrel{\text{iid}}{\sim} P$ ;
- the infimum is over all learning methods that output a hypothesis  $\hat{f} \in \mathcal{F}$  that depends on the training sample;
- the supremum is over all probability distributions over  $\mathcal{X} \times \mathcal{Y}$ .

On the other hand, in the realizable case (i.e. PAC learning), we have

$$\inf_{\hat{f}} \sup_{P \in \mathcal{P}_{\mathcal{F}}} \Pr\left( R(\hat{f}) > \frac{2\left(V \log \frac{2en}{V} + \log \frac{2}{\delta}\right)}{n} \right) \le \delta, \tag{1}$$

where the probability and infimum are as before, but now the supremum is restricted to  $\mathcal{P}_{\mathcal{F}}$ , the set of all distributions P over  $\mathcal{X} \times \mathcal{Y}$  for which the label Y = c(X) for some  $c \in \mathcal{F}$ .

Each of the above bounds was established by showing that a particular learning method, empirical risk minimization, obtains low risk with high probability no matter the distribution generating the data. Thus, if  $\mathcal{F}$  has finite dimension, a problem is "learnable" in that, no matter the distribution, the gap between the error our learning method achieves and the best possible error using  $\mathcal{F}$  converges to zero as the sample size increases. One might then ask if there is a converse:

Is it necessary for the VC dimension to be finite in order for a problem to be learnable?

As we will see today, the answer is yes. The VC dimension thus *characterizes* the classes  $\mathcal{F}$  for which learnability holds.

<sup>&</sup>lt;sup>1</sup>Interestingly, the "min" player could perform well even though it was straightjacketed (so to speak) by being forced to be a proper learner (which restricts  $\hat{f}$  to lie in  $\mathcal{F}$ ); we could have entertained e.g. allowing predictions according to weighted majority votes over  $\mathcal{F}$ , but the above bounds hold without broadening the infimum to this larger class.

#### 2 A minimax lower bound for the realizable case

Ignoring logarithmic factors, the upper bound (1) is essentially unimprovable. In all the bounds below, the learning method  $\hat{f}$  can be any learning method, not necessarily one restricted to taking values in the set  $\mathcal{F}$ .

**Theorem 1.** Let  $\mathcal{F}$  satisfy  $VCdim(\mathcal{F}) = V + 1$ . Then in the realizable case, for  $n \geq 15$ ,

$$\inf_{\hat{f}} \sup_{P \in \mathcal{P}_{\mathcal{F}}} \Pr \left( R(\hat{f}) \geq \frac{V-1}{12n} \right) \geq \frac{1}{10}.$$

We will not prove the above result (for a proof, see Theorem 14.2 of the book of Devroye, Györfi, and Lugosi (1996)). Instead, we'll prove a related lower bound on the *expected* risk, where the expectation is over the training sample:

**Theorem 2.** Let  $\mathcal{F}$  be a class for which  $VCdim(\mathcal{F}) = V + 1$ . Then for any  $n \geq V$ ,

$$\inf_{\hat{f}} \sup_{P} \mathsf{E}\left[R(\hat{f})\right] \geq \frac{V}{2en} \left(1 - \frac{1}{n}\right).$$

Note that the choice V + 1 (instead of V) is to slightly simply the proof.

Proof. We begin by constructing a special family of probability distributions. Observe that since  $VCdim(\mathcal{F}) = V + 1$ , there exists a set of points  $\{x_0, x_1, \dots, x_V\}$  that is shattered by  $\mathcal{F}$ . Let  $\mathcal{P}_V = \{P_b : b \in \{0,1\}^b\}$  be a family of  $2^V$  probability distributions. Let  $\varepsilon > 0$  be some constant to be determined later. We take all the probability distributions to have the same marginal distribution over  $\mathcal{X}$  which concentrates on  $\{x_0, x_1, \dots, x_V\}$ . Under this distribution,  $Pr(X = x_j) = \varepsilon$  for  $j \in [V]$ , and  $Pr(X = x_0) = 1 - \varepsilon$ . Under distribution  $P_b$ , let  $Y = f_b(X)$ , with  $f_b$  defined as

$$f_b(X) = \begin{cases} b_j & \text{if } j \in [V], \\ 0 & \text{if } j = 0. \end{cases}$$

The idea behind this construction is to let one of these  $2^V$  distributions be the one that generates the data. Learner will then need to identify the correct  $b \in \{0,1\}^V$  in order to perform well; for every bit  $b_j$  that Learner misses, it pays additional risk  $\varepsilon$ . However, most of the probability mass is on the "garbage" point  $x_0$ , which reveals no information about b. Only samples falling in the set  $\{x_1, \ldots, x_V\}$  reveal information about which distribution is correct, and this set has probability only  $V\varepsilon$ . Now, onwards with the proof.

Let  $Z^n = ((X_1, Y_1), \dots, (X_n, Y_n))$ , and let  $\hat{f}_{Z^n}$  be arbitrary classifier (that depends on  $Z^n$ ). The first step is to lower bound the supremum over b by the expectation over a random variable B distributed uniformly over  $\{0,1\}^V$ :

$$\sup_{b \in \{0,1\}^V} \mathsf{E}_{Z^n} \left[ R(\hat{f}_{Z^n}) \right] \ge \mathsf{E}_B \left[ \mathsf{E}_{Z^n} \left[ R(\hat{f}_{Z^n}) \right] \right].$$

It will be useful to rewrite the RHS in terms of a conditional probability, as we then can leverage properties of the Bayes risk of a decision problem:

$$\mathsf{E}_{B}\left[\mathsf{E}_{Z^{n}}\left[R(\hat{f}_{Z^{n}})\right]\right] = \mathsf{E}\left[\mathsf{E}\left[\mathbf{1}\left[\hat{f}_{Z^{n}}(X) \neq f_{B}(X)\right] \mid Z^{n}, X\right]\right]$$
$$= \mathsf{E}\left[\Pr\left(\hat{f}_{Z^{n}}(X) \neq f_{B}(X) \mid Z^{n}, X\right)\right]. \tag{2}$$

Next, we analyze the conditional probability inside the expectation:

$$\Pr\left(\hat{f}_{Z^{n}}(X) \neq f_{B}(X) \mid Z^{n}, X\right)$$

$$= \mathbf{1} \left[\hat{f}_{Z^{n}}(X) = 0\right] \cdot \Pr\left(f_{B}(X) = 1 \mid Z^{n}, X\right)$$

$$+ \mathbf{1} \left[\hat{f}_{Z^{n}}(X) = 1\right] \cdot \Pr\left(f_{B}(X) = 0 \mid Z^{n}, X\right)$$

$$\geq \min\left\{\Pr\left(f_{B}(X) = 1 \mid Z^{n}, X\right), 1 - \Pr\left(f_{B}(X) = 1 \mid Z^{n}, X\right)\right\}$$

$$= \min\left\{\eta(Z^{n}, X), 1 - \eta(Z^{n}, X)\right\}, \tag{3}$$

where  $\eta(Z^n, X) = \Pr(f_B(X) = 1 \mid Z^n, X)$ . From the last line above, we can see that we have arrived at a quantity that is completely analogous to the (conditional) Bayes risk, where the conditioning is on X (as usual) but now also  $Z^n$ .

It remains to lower bound the expectation of (3); let's first get a handle on  $\eta(Z^n, X)$ . Suppose that  $X \in \{X_1, \dots, X_n, x_0\}$ ; then the label of X is known and hence  $\eta(Z^n, X)$  is equal to either 0 or 1. On the other hand, if  $X \notin \{X_1, \dots, X_n, x_0\}$ , then, among the distributions in  $\mathcal{P}_V$  that are consistent with the labeling of  $X_1, \dots, X_n$ , precisely half label X as 1 and half label X as 0, so in this case we have  $\eta(Z^n, X) = \frac{1}{2}$ . It therefore follows that (3) is equal to

$$\frac{1}{2}\mathbf{1}[X\notin\{X_1,\ldots,X_n,x_0\}],$$

and hence (2) is equal to

$$\frac{1}{2}\Pr\left(X\notin\left\{X_{1},\ldots,X_{n},x_{0}\right\}\right).$$

Considering the V possible values of X (as  $x_0$  is excluded in the above event), this probability is

$$\frac{1}{2} \sum_{j=1}^{V} \Pr(X = x_j) \prod_{i=1}^{n} \Pr(X_i \neq x_j) = \frac{1}{2} \sum_{j=1}^{V} \varepsilon (1 - \varepsilon)^n = \frac{V}{2} \varepsilon (1 - \varepsilon)^n.$$

Next, setting  $\varepsilon = \frac{1}{n}$  yields

$$\frac{V}{2n}\left(1-\frac{1}{n}\right)\left(1-\frac{1}{n}\right)^{n-1}.$$

The result follows since  $\left(1-\frac{1}{n}\right)^{n-1} \geq \frac{1}{e}$ . To see this, note that this inequality is equivalent to

$$(n-1)\log\left(1-\frac{1}{n}\right) \ge -1 \quad \Longleftrightarrow \quad \frac{1}{n-1} \ge \log\left(\frac{n}{n-1}\right) \quad \Longleftrightarrow \quad e^{\frac{1}{n-1}} \ge \frac{n}{n-1},$$

and the claim follows from  $\frac{n}{n-1} = 1 + \frac{1}{n-1}$  and the inequality  $e^x \ge 1 + x$ .

## 3 Lower bound, agnostic setting

A similar lower bound can be worked out in the agnostic case.

**Theorem 3.** There are constants  $c_1, c_2 > 0$  such that, for any  $\mathcal{F}$  satisfying  $VCdim(\mathcal{F}) = V$ , for any learning method  $\hat{f}$ , there exists a distribution P over  $\mathcal{X} \times \mathcal{Y}$  for which

$$\Pr\left(R(\hat{f}) - R(f^*) > c_1 \sqrt{\frac{V}{n}}\right) > c_2.$$

# 4 Lower bounds on the expected risk actually tell you a lot of about the achievable high probability upper bounds on the risk

Suppose someone approaches you on the street and says that they have a learning algorithm for which, under any distribution  $P \in \mathcal{P}_{\mathcal{F}}$  (i.e. the realizable case), satisfies for some A, c > 0

$$\Pr\left(R(\hat{f}) > \varepsilon\right) \le Ae^{-cn\varepsilon}.\tag{4}$$

Should you believe them? Well, if their claim is true, then, for any  $\gamma \geq 0$ ,

$$\begin{split} \mathsf{E}[R(\hat{f})] &= \int_0^1 \Pr(R(\hat{f}) > \varepsilon) d\varepsilon \\ &\leq \gamma + \int_\gamma^1 \Pr(R(\hat{f}) > \varepsilon) d\varepsilon \\ &\leq \gamma + A \int_\gamma^1 e^{-cn\varepsilon} d\varepsilon \\ &= \gamma + \frac{A}{cn} \left( e^{-cn\gamma} - e^{-n} \right) \\ &\leq \gamma + \frac{A}{cn} e^{-cn\gamma}. \end{split}$$

Taking  $\gamma = \frac{\log A}{cn}$  yields the upper bound

$$\mathsf{E}[R(\hat{f})] \le \frac{\log A}{cn} + \frac{1}{cn}.$$

In light of Theorem 2, it must be the case that

$$\frac{\log A}{cn} + \frac{1}{cn} \ge \frac{V}{2en} \left( 1 - \frac{1}{n} \right),$$

and so

$$A \ge \exp\left(\frac{cV}{2e}\left(1 - \frac{1}{n}\right) - 1\right).$$

Thus, unavoidably, A must depend on the VC dimension in a bound of the form (4).

#### References

Luc Devroye, László Györfi, and Gabor Lugosi. A Probabilistic Theory of Pattern Recognition, volume 31. Springer Science & Business Media, 1996.